

PTO/SB/08A (08-00)

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February 1, 2001							
Koichiro TANAKA							
mber 740756-2256							

U.S. PATENT DOCUMENTS								
Examiner Initials			Name of Patentee or Applicant of Cited	Date of Publication of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
THE STATE OF THE S		Number Kind Code <sup>2</sup> (if known)		Document	MM-DD-YYYY			
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Examiner Initials	Cite No. <sup>1</sup>	F	Foreign Patent Document	Name of Patentee or	Date of Publication of Cited Document	Pages, Columns, Lines, Where Relevant Passages or		
		Office <sup>3</sup>	Kind Code Number <sup>4</sup> (if known		MM-DD-YYYY	Relevant Figures Appear	T <sup>6</sup>	
B		Japan	10-258383	Kazutaka et al.	09/29/1998		Abstract	
A)	-	Japan	07-130652	Fukunaga et al.	05/19/1995		Abstract	
			OTHER PR	IOR ART – NON PATENT LITE	RATURE DOCUMENTS			
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<sup>&</sup>lt;sup>1</sup> Unique citation designation number. <sup>2</sup> See attached Kinds of U.S. Patent Documents. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). 4 For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. 5 Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.

<sup>&</sup>lt;sup>1</sup>Unique citation designation number. <sup>2</sup> Applicant is to place a check mark here if English language Translation is attached.



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Substitute for form 1449A/PTO Complete if Known 09/774,637 Application Number ্বীমূদORMATION DISCLOSURE February 1, 2001 Filing Date ATEMENT BY APPLICANT Koichiro TANAKA First Named Inventor (use as many sheets as necessary) 2815 Group Art Unit J. Diaz Examiner Name of Attorney Docket Number 0756-2256

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		OTHER PRIOR	ART – NON PATENT LITE	RATURE DOCUMENTS		
Examiner Initials	Cite No.1		or (in CAPITAL LETTERS), urnal, serial, symposium, catalopublisher, city and/or count	og, etc.)., date, page(s), volum		T <sup>2</sup>
D		U.S. Patent Application Notes of the receipt, "Laser Irradiation Koichiro TANAKA et al.,	Apparatus and Metho			

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<sup>&</sup>lt;sup>1</sup> Unique citation designation number. <sup>2</sup> See attached Kinds of U.S. Patent Documents. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.

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Substitute for form 1449 A/F	OTO		C	Complete if Known
INFORMATIO	N DISC	TOSURE	Application Number	09/774,637
		LUSURE	Filing Date	February 1, 2001
STATEMENT BY APPLICANT		First Named Inventor	Koichiro TANAKA	
(use as many sh	eets as necess	sary)	Group Art Unit	2815
60			Examiner Name	J. Diaz
2002 3	of	1	Attorney Docket Number	0756-2256

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	- V	OTHER PRIOR	ART – NON PATENT LITE	RATURE DOCUMENTS		
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.)., date, page(s), volume-issue number(s), publisher, city and/or country where published.				T <sup>2</sup>
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3		Y. Helen et al., Reproduci Transistors Involving Puls 300				

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